Lucent Technologies
Bell Labs Innovations

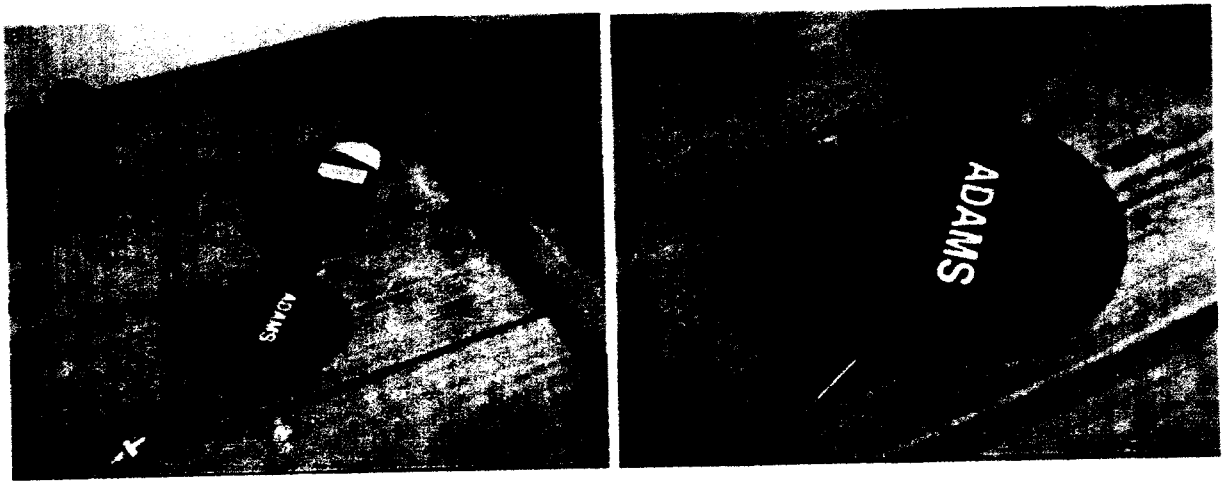
Lucent Technologies, Oklahoma City, OATS EMC Test Laboratory

subject: **FCC RMS Data Measurement for Adams Electronics Inc.**

Date: **28 August 1998**
from: **OATS EMC LAB**
Org. 3814
x3573 OC
Rept No: **28_Aug_1998_Adams**

1. **Statement of Test Results Obtained from RMS testing of the Adams AD15/AS2600S Scanner.**

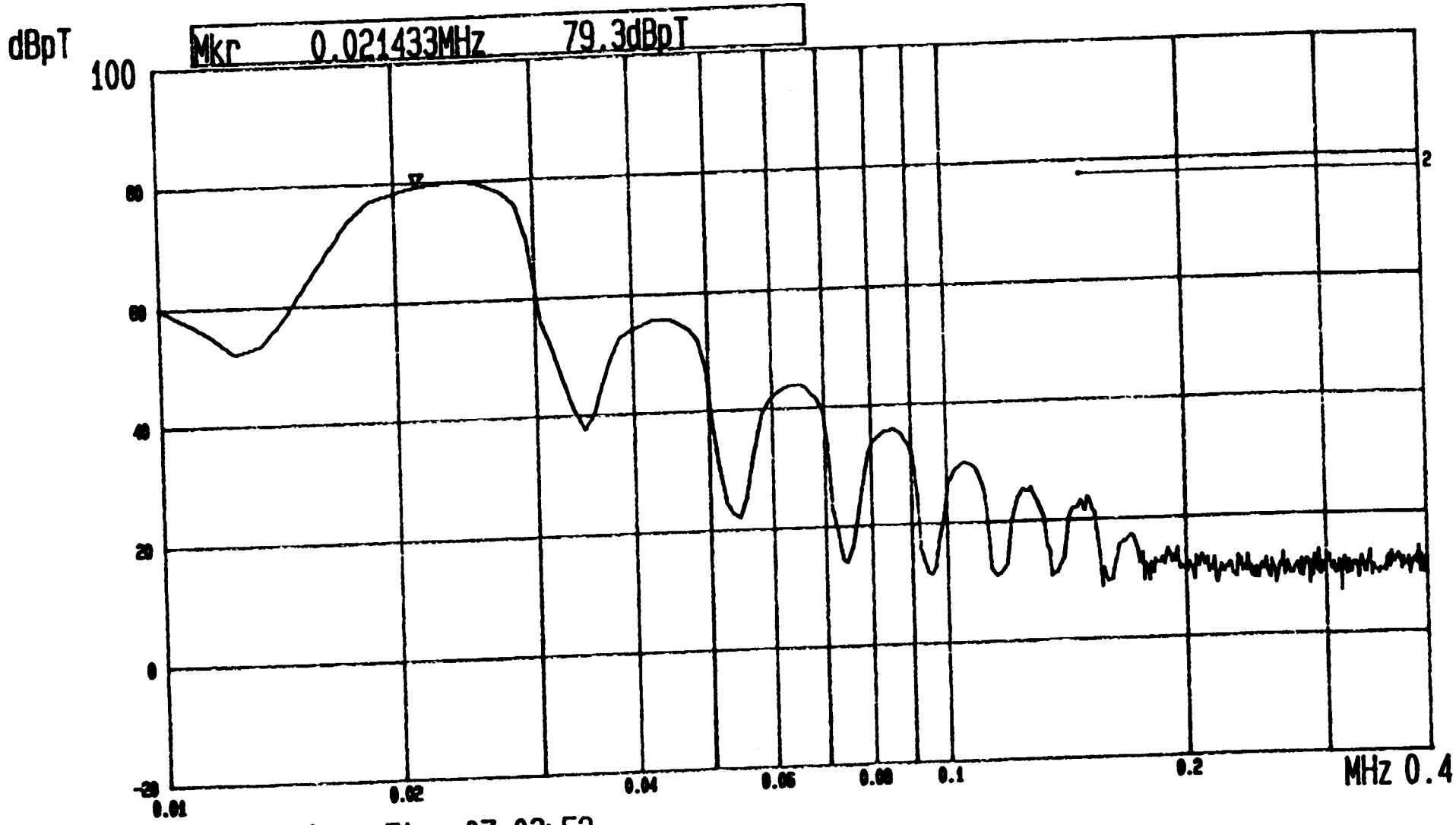
The AD15/AD2600S was scanned using a Rohde & Schwarz test receiver in contentious scan mode to measure the RMS noise output of the EUT in dBpT. The EUT was placed in a shielded enclosure with the EUT operating in maximum input sensitivity signal mode. The graphs, tables, and pictures show the test setup for measuring the EUT's noise signal output.



Pictures of EUT under test in shielded enclosure.

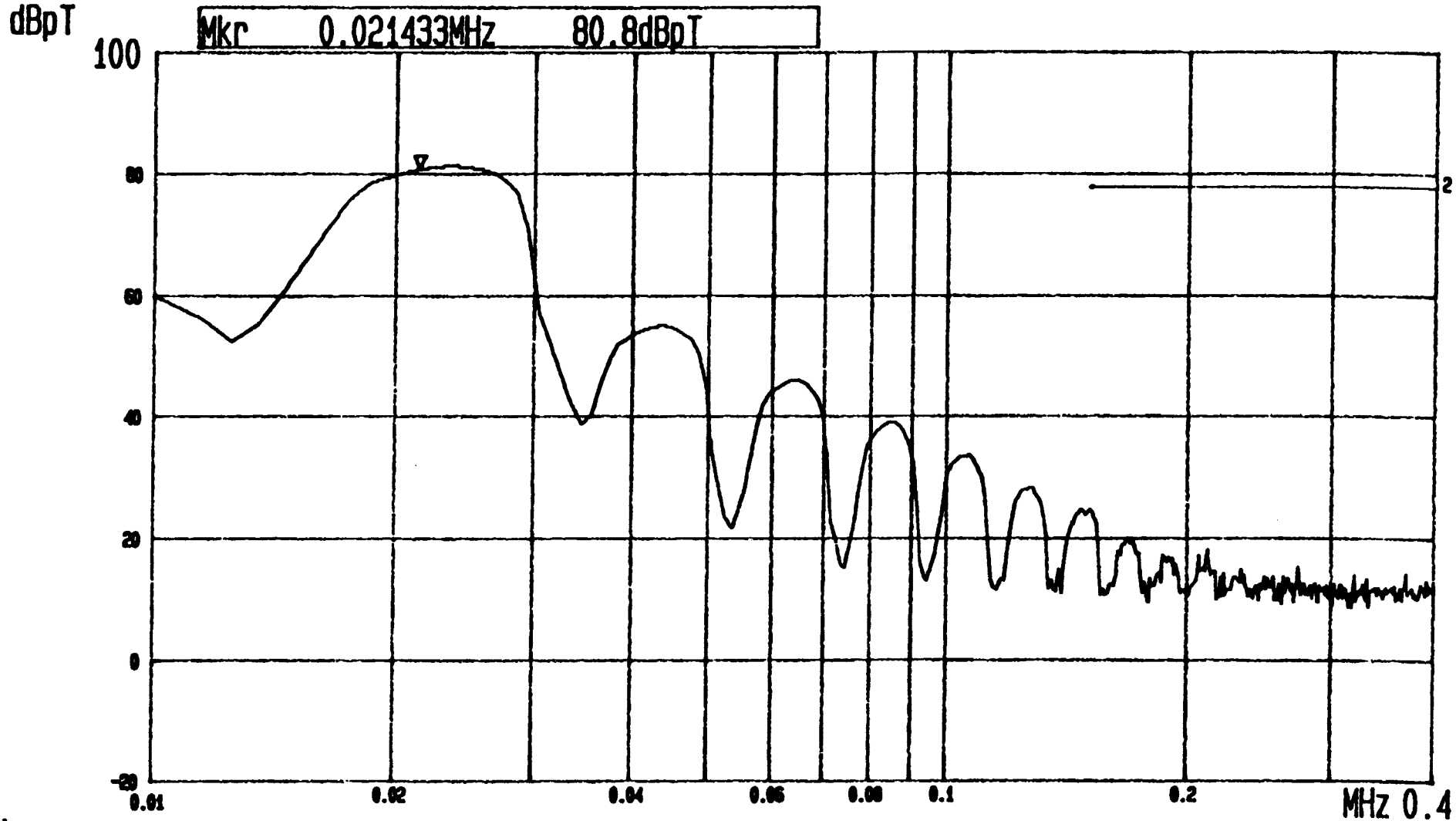
Unit #1		Unit #2	
Frequency	Level dBpT	Frequency	dBpT
0.0214	79.3	0.0214	80.8
0.0450	56.1	0.0450	56.8
0.0650	43.6	0.0650	43.9
0.0850	35.2	0.0850	35.6
0.1100	30.1	0.1100	30.8
0.1300	26.7	0.1300	28.5
0.1600	24.5	0.1600	26.5
0.1700	23.5	0.1700	25.5
0.1800	18.5	0.1800	20.0
0.1900	16.0	0.1900	17.8

EMC Test Engineer: Richard L. Robles Date: 31-Aug-98



| --- Date 28.AUG '98 Time 07:03:52
AD15/AD2600S

UNIT #1



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AD15/AD2600S

UNIT 2